

PATENT NUMBER and  
ISSUE DATE

U.S. UTILITY Patent Application

APPL NUM	FILING DATE	CLASS	SUBCLASS	GAU	EXAMINER
10080543	02/25/2002	356	630	2877	<i>Pi om</i>

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\*\*CONTINUING DATA VERIFIED: *none*

\*\* FOREIGN APPLICATIONS VERIFIED: *yes*  
REPUBLIC OF KOREA 2001-51016 08/23/2001

PG-PUB	DO NOT PUBLISH <input type="checkbox"/>	RESCIND <input type="checkbox"/>
Foreign priority claimed	<i>yes</i> <input checked="" type="checkbox"/> yes <input type="checkbox"/> no	ATTORNEY DOCKET NO
35 USC 119 conditions met	<i>yes</i> <input checked="" type="checkbox"/> yes <input type="checkbox"/> no	P22019
Verified and Acknowledged Examiners's initials <i>HP</i>		
TITLE : Apparatus for and method of measuring thickness of materials using the focal length of a lensed fiber		

U.S. DEPT. OF COMM / PAT. & TM-PTO-436L (Rev. 12-94)

NOTICE OF ALLOWANCE MAILED		CLAIMS ALLOWED	
		Total Claims	Print Claim for O.G
Assistant Examiner		DRAWING	
		Sheets Drwg.	Figs. Drwg. Print Fig.
Primary Examiner		Application Examiner	
PREPARED FOR ISSUE			
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